


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540968	<b>Applicant(s)/Patent Under Reexamination</b>  SUN ET AL.
	<b>Examiner</b>  Hsieh, Brandon	<b>Art Unit</b>  21285

SEARCHED			
Class	Subclass	Date	Examiner
264	308,40.1	6/13/2007	BH
425	375	6/13/2007	BH
264	178F	6/13/2007	BH
703	11	6/13/2007	BH

SEARCH NOTES		
Search Notes	Date	Examiner
Google (search note attached)	6/13/2007	BH
Consulted with examiner Graig Dwin	6/1/2007	BH
Consulted with examiner Robert Davis	6/1/2007	BH
Consulted with examiner Leo Tentoni	6/1/2007	BH
Sciencedirect (search note attached)	6/13/2007	BH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner